

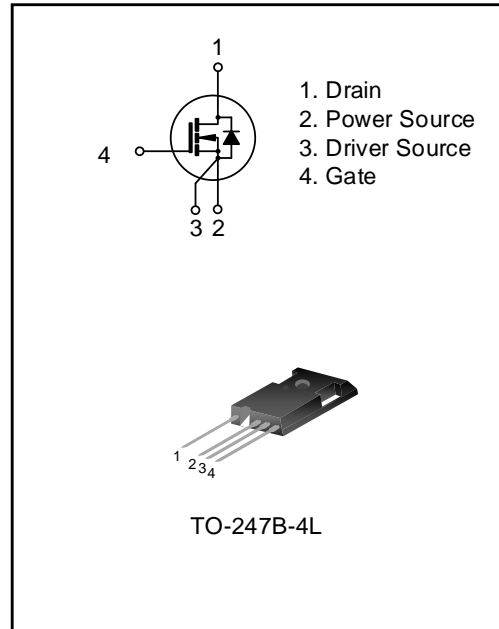
## 13.5mΩ, 1200V SiC MOS POWER TRANSISTOR

### DESCRIPTION

SCDP120R013N2P4B is an N-channel enhancement mode high voltage power MOSFET produced using Silan's Silicon Carbide technology. It achieves low conduction loss and switching losses. It leads the design engineers to their power converters with high efficiency, high power density, and superior thermal behavior. Furthermore, it's universal applicable, i.e., suitable for switching power supplies, inverters, and DC-DC converters.

### FEATURES

- ◆ 138A, 1200V,  $R_{DS(on)(typ.)} = 13.5m\Omega @ V_{GS}=15V$
- ◆ Silicon Carbide technology
- ◆ Low switching loss
- ◆ Low reverse recovery charge
- ◆ Reduced requirement for heat dissipation
- ◆ 100% avalanche tested
- ◆ Pb-free lead plating
- ◆ RoHS compliant



### KEY PERFORMANCE PARAMETERS

Characteristics	Ratings	Unit
$V_{DS}$	1200	V
$V_{GS(th)}$	1.8~3.6	V
$R_{DS(on),max.}$	17	mΩ
$I_{D,pulse}$	276	A
$Q_{g,typ.}$	226	nC

### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SCDP120R013N2P4B	TO-247B-4L	P120R013N2	Halogen free	Tube

**ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED,  $T_J=25^{\circ}\text{C}$ )**

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Voltage	$V_{DS}$	--	--	--	1200	V
Gate-source Voltage (Static)	$V_{GS}$	--	-4	--	15	V
Gate-source Voltage (Dynamic)	$V_{GS}$	AC( $f>1\text{Hz}$ )	-8	--	19	V
Drain Current (Note 1)	$I_D$	$V_{GS}=15\text{V}$ , $T_C=25^{\circ}\text{C}$	--	--	138	A
		$V_{GS}=15\text{V}$ , $T_C=100^{\circ}\text{C}$	--	--	97	A
Pulsed Drain Current (Note 2)	$I_{DM}$	$T_C=25^{\circ}\text{C}$	--	--	276	A
Power Dissipation (Note 3)	$P_D$	$T_C=25^{\circ}\text{C}$	--	--	469	W
Single Pulsed Avalanche Energy	$E_{AS}$	$L=5\text{mH}$ , $V_{DD}=100\text{V}$ , $R_G=25\Omega$ , starting temperature $T_J=25^{\circ}\text{C}$	--	--	1562	mJ
Single Pulsed Current	$I_{AS}$	--	--	--	25	A
Operation Junction Temperature Range	$T_J$	--	-55	--	175	$^{\circ}\text{C}$
Storage Temperature Range	$T_{stg}$	--	-55	--	175	$^{\circ}\text{C}$
Continuous Diode Forward Current	$I_S$	$T_C=25^{\circ}\text{C}$ , integral reverse P-N junction diode in the MOSFET	--	--	138	A
Diode Pulse Current	$I_{S,pulse}$		--	--	276	A

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Thermal Resistance, Junction-case, Bottom	$R_{\theta JC}$	--	--	--	0.32	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-ambient	$R_{\theta JA}$	--	--	--	40	$^{\circ}\text{C/W}$
Soldering Temperature (in line)	$T_{sld}$	$15^{+2}_{-0}$ sec, 1time	--	--	260	$^{\circ}\text{C}$

## ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, $T_J=25^{\circ}\text{C}$ )

### Static characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	1200	--	--	V
Drain-source Leakage Current	$I_{DSS}$	$V_{DS}=1200V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	--	--	50	$\mu A$
		$V_{DS}=1200V, V_{GS}=0V, T_J=150^{\circ}\text{C}$	--	1.0	--	$\mu A$
Gate-source Leakage Current	$I_{GSS}$	$V_{GS}=15V, V_{DS}=0V$	--	--	1.0	$\mu A$
		$V_{GS}=-4V, V_{DS}=0V$	--	--	-1.0	$\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=20mA, T_J=25^{\circ}\text{C}$	1.8	--	3.6	V
		$V_{GS}=V_{DS}, I_D=20mA, T_J=175^{\circ}\text{C}$	--	1.6	--	V
Static Drain-source On State Resistance	$R_{DS(on)}$	$V_{GS}=15V, I_D=75A$	--	13.5	17.0	$m\Omega$
Transconductance	$G_{fs}$	$V_{DS}=20V, I_D=75A, T_J=25^{\circ}\text{C}$	--	85	--	S
		$V_{DS}=20V, I_D=75A, T_J=175^{\circ}\text{C}$	--	63	--	S
Gate Resistance	$R_G$	$f=1MHz$	--	2.9	--	$\Omega$

### Dynamic characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Input Capacitance	$C_{iss}$	$f=1MHz, V_{GS}=0V, V_{DS}=1000V$	--	6713	--	pF
Output Capacitance	$C_{oss}$		--	210	--	
Reverse Transfer Capacitance	$C_{rss}$		--	15	--	
Output Capacitance Loss	$E_{oss}$		--	121	--	$\mu J$
Turn-on Switching Loss	$E_{on}$	$V_{DS}=800V, V_{GS}=-4/15V, R_G=2.5\Omega, I_D=75A, T_J=175^{\circ}\text{C}$	--	0.96	--	mJ
Turn-off Switching Loss	$E_{off}$		--	0.97	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=800V, V_{GS}=-4/15V, R_G=2.5\Omega, I_D=75A, L=50\mu H$ (Notes 4,5)	--	21	--	ns
Turn-on Rise Time	$t_r$		--	14	--	
Turn-off Delay Time	$t_{d(off)}$		--	80	--	
Turn-off Fall Time	$t_f$		--	25	--	
Total Gate Charge	$Q_g$	$V_{DD}=800V, V_{GS}=-4/15V, I_D=75A$ (Notes 4,5)	--	226	--	nC
Gate-source Charge	$Q_{gs}$		--	59	--	
Gate-drain Charge	$Q_{gd}$		--	50	--	

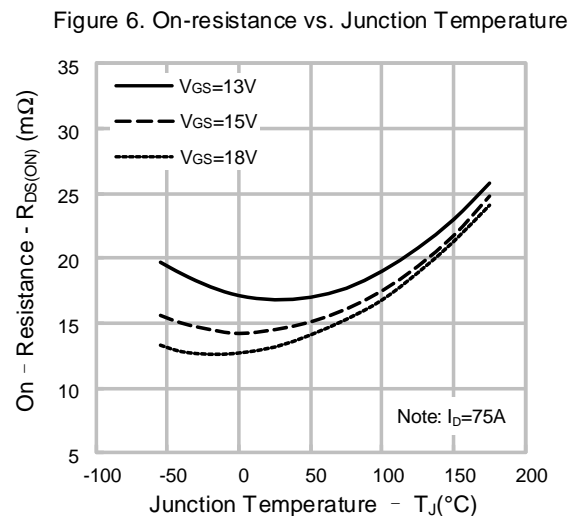
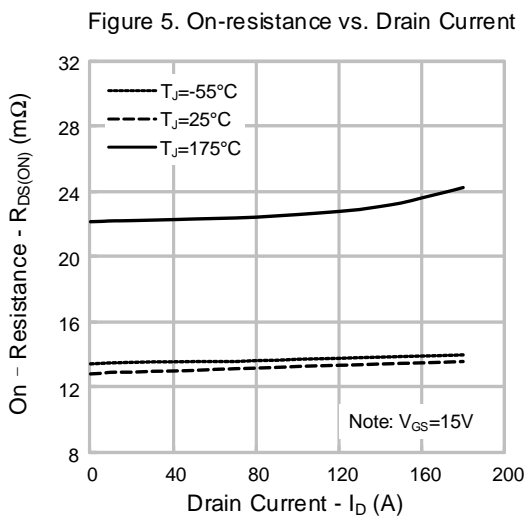
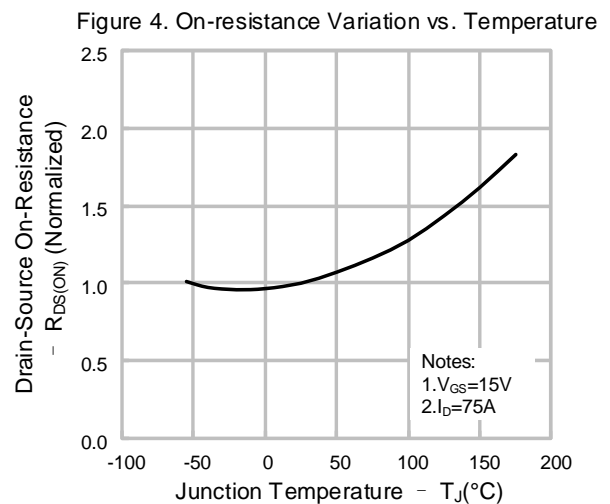
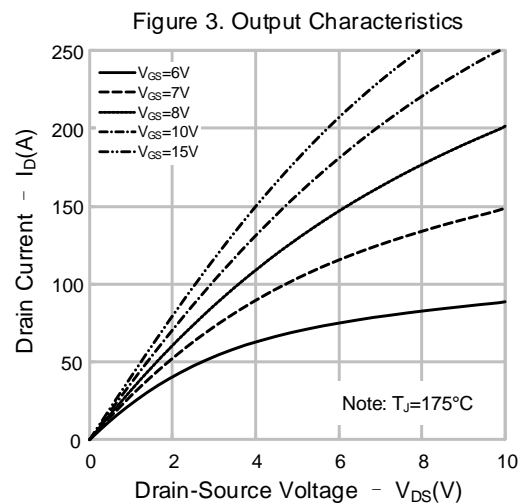
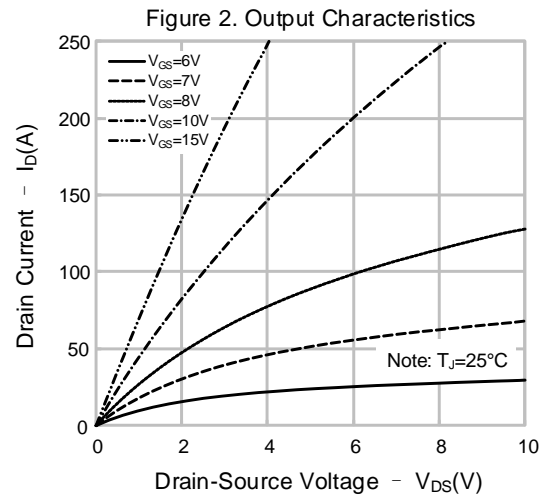
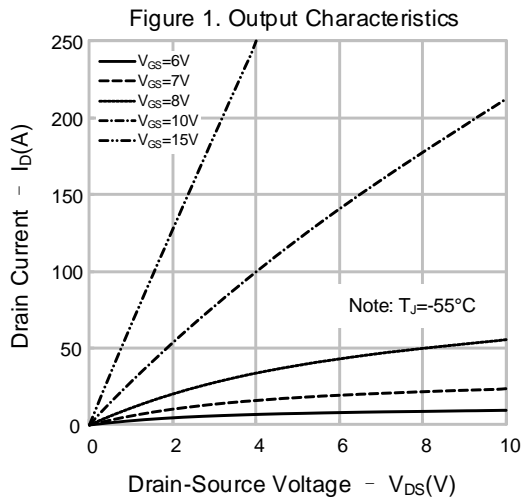
## Reverse diode characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Diode Forward Voltage	$V_{SD}$	$I_S=75A$ , $V_{GS}=-4.0V$	--	--	10	V
Reverse Recovery Time	$T_{rr}$	$I_S=75A$ , $V_{GS}=-4.0V$ , $V_R=800V$ ,	--	22	--	ns
Reverse Recovery Charge	$Q_{rr}$	$dI_F/dt=6500A/\mu s$ , $T_J=175^\circ C$	--	798	--	nC
Reverse Recovery Peak Current	$I_{rrm}$	(Note 4)	--	55	--	A

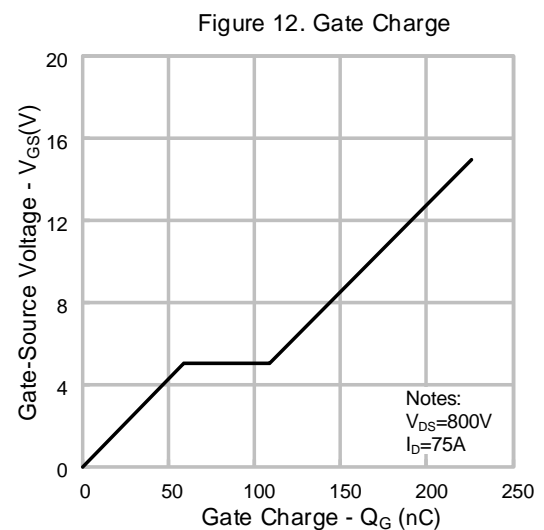
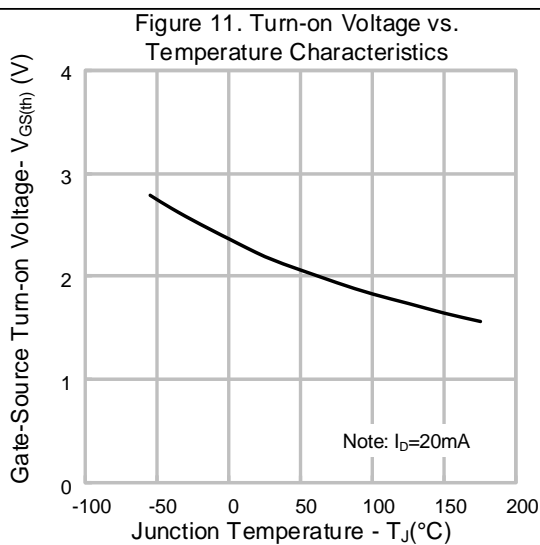
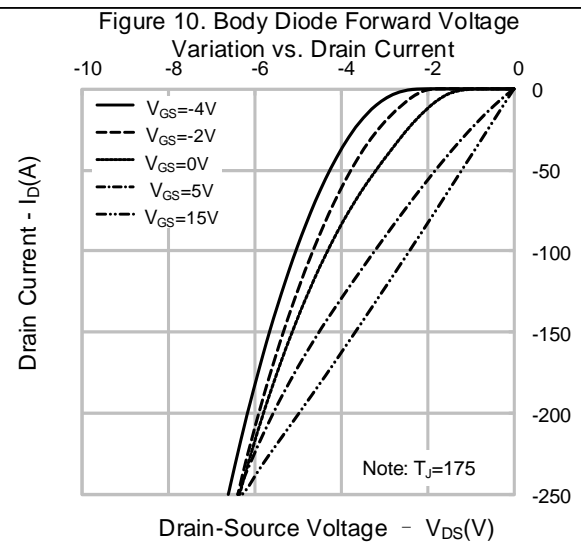
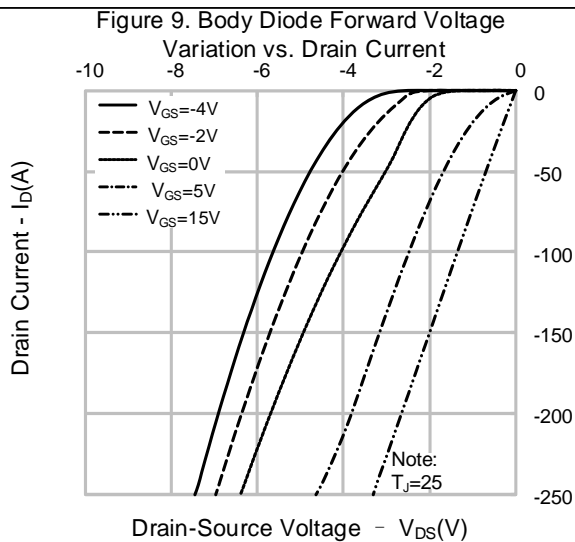
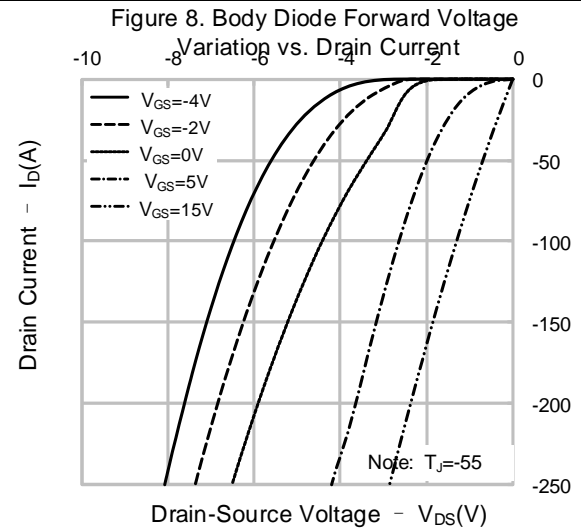
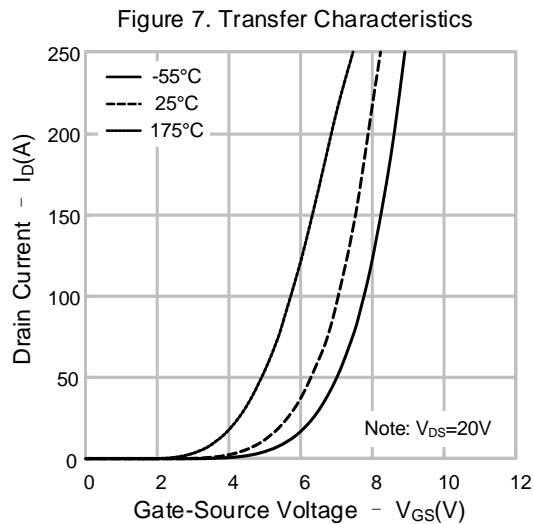
### Notes:

1. The rated value only refers to the maximum absolute value at the case temperature of 25°C in the specification. If the case temperature is higher than 25°C, it should be derated according to the actual environmental conditions;
2. Pulse time 5μs; pulse width is limited by the maximum junction temperature;
3. The dissipation power will change with temperature, derating above 25°C: 3.13W/°C;
4. Pulse Test: Pulse width ≤300μs, Duty cycle≤2%;
5. Essentially independent of operating temperature.

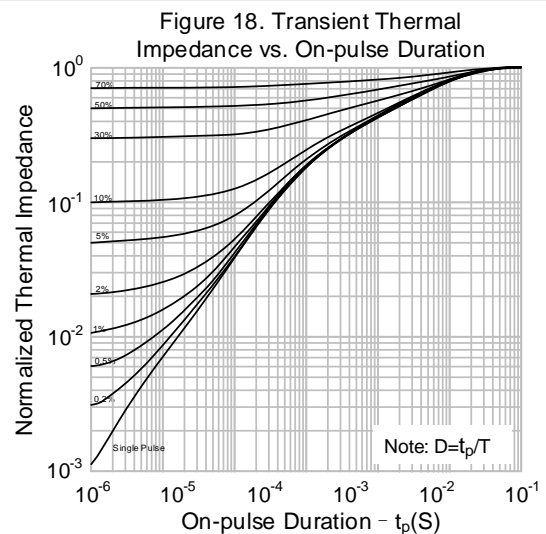
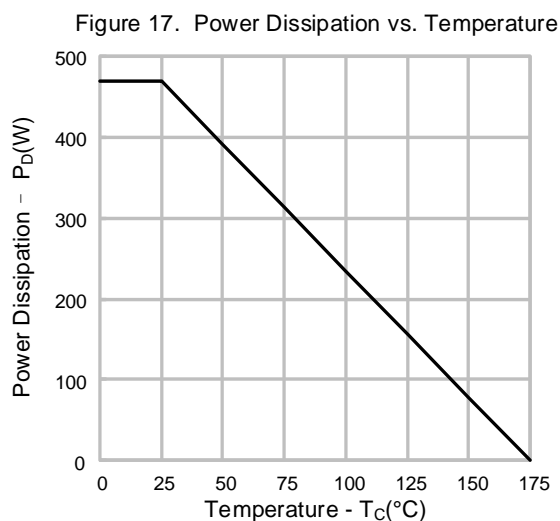
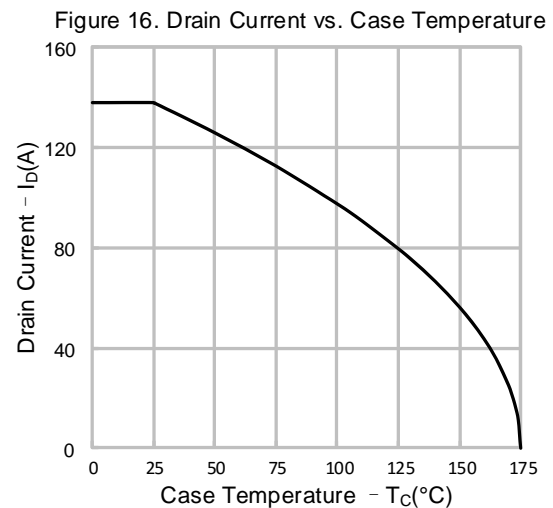
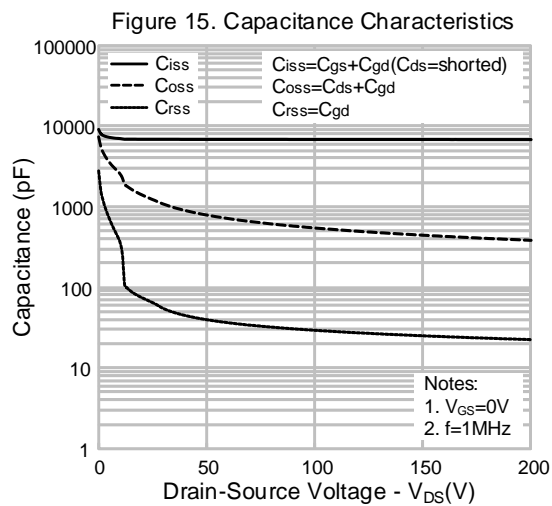
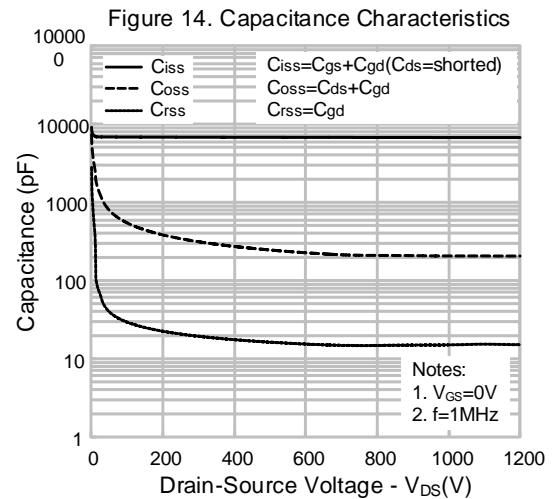
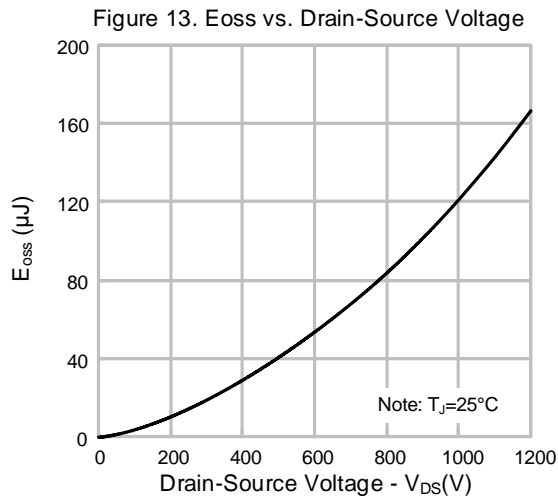
## TYPICAL CHARACTERISTICS



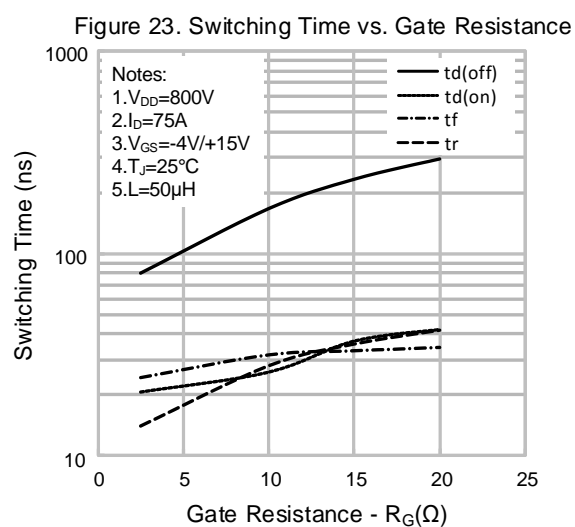
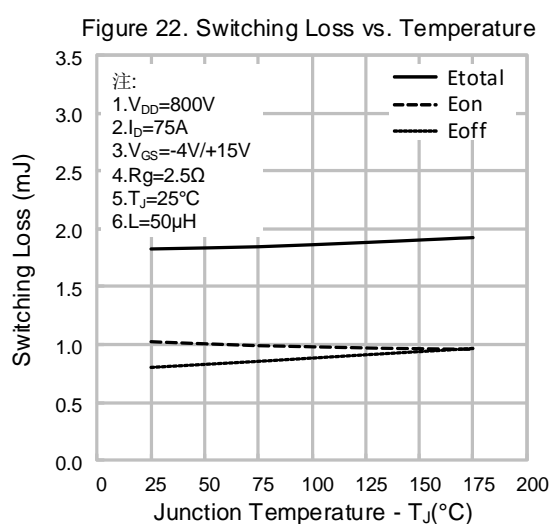
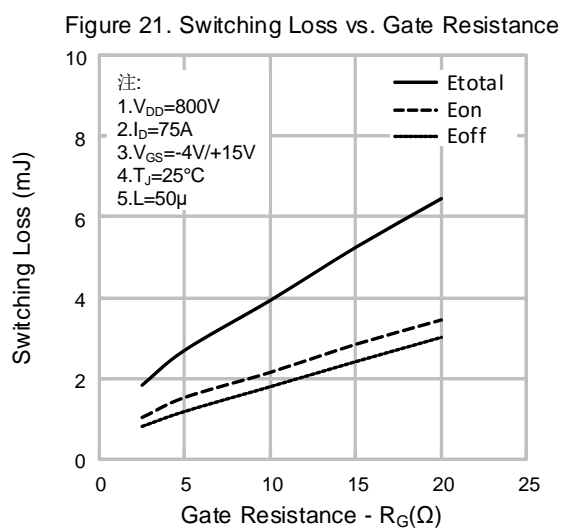
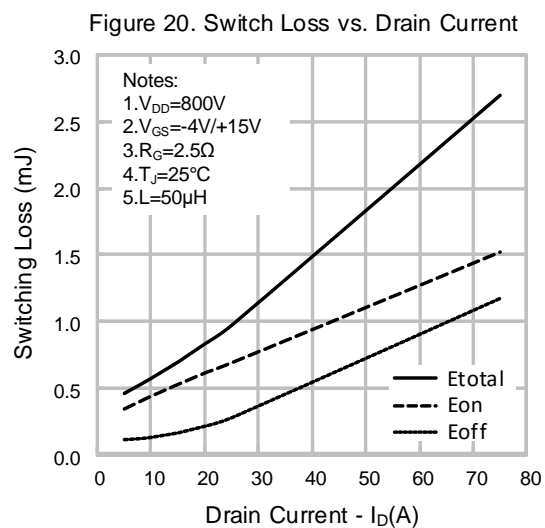
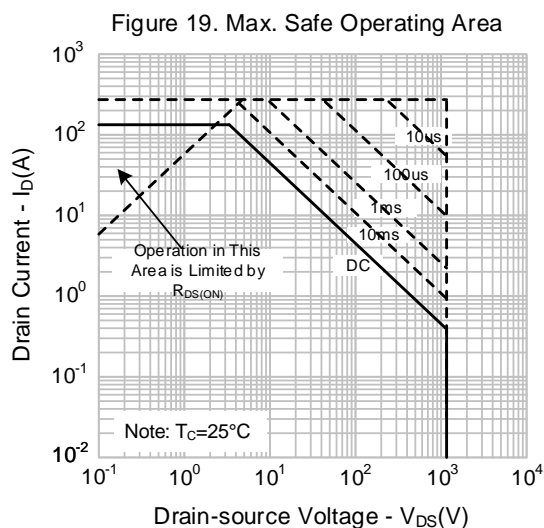
**TYPICAL CHARACTERISTICS (CONTINUED)**



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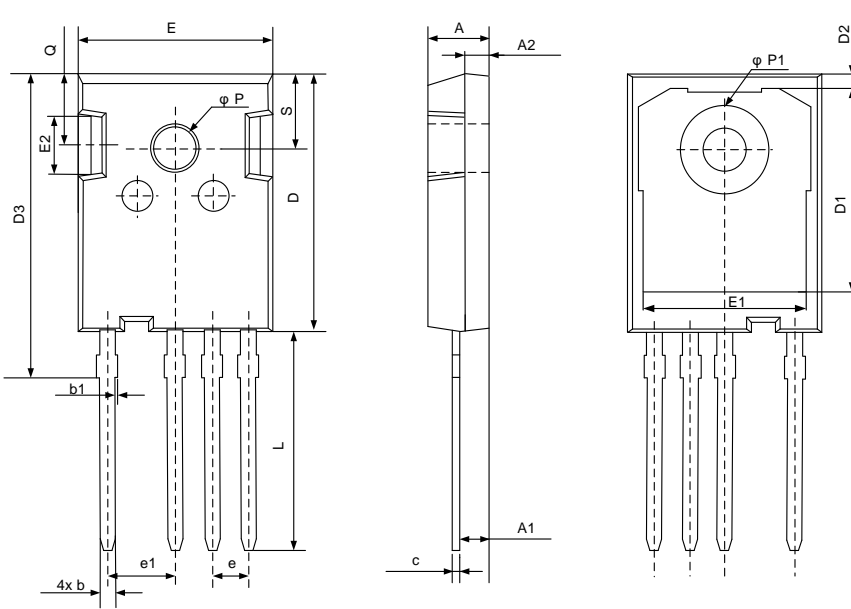
**TYPICAL CHARACTERISTICS (CONTINUED)**



## PACKAGE OUTLINE

TO-247B-4L

UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16	—	1.29
b1	0	—	0.20
c	0.59	—	0.66
D	20.90	21.00	21.10
D1	16.25	16.55	16.85
D2	1.05	1.20	1.35
D3	24.97	25.12	25.27
E	15.70	15.80	15.90
E1	13.10	13.30	13.50
E2	4.90	5.00	5.10
e	2.44	2.54	2.64
e1	4.98	5.08	5.18
L	19.80	19.92	20.10
P	3.50	3.60	3.70
P1	—	—	7.40
Q	5.60	—	6.00
S	6.15 BSC		



### MOS DEVICES OPERATE NOTES:

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.

**Important notice :**

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Rev.: 1.0

Revision History:

1. First release

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